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SPECIAL ISSUE ON MICRO AND NANO-SCALE DEFORMATION MEASUREMENT

CONTENTS

- | | |
|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|
| Guest Editorial
Huimin Xie | 325 |
| Microdeformation measurement via single-element extended digital image correlation
J Chen, X Zhang, and R Wang | 327 |
| Accurate displacement field measurement with scanning electron microscopy imaging
T Arikawa, G Murasawa, and S Yoneyama | 337 |
| Microscale digital image correlation study of irradiation induced ductile-to-brittle transition in polyethylene
J Lambros and J Patel | 347 |
| Filtering out slow-scan drifts in atomic force microscopy images
H Teyssedre, S Roux, G Régnier, and A Tracz | 361 |
| Microelasticity of red blood cells in sickle cell disease
J L Maciaszek, B Andemariam, and G Lykotrafitis | 368 |
| Scale-independent approach to deformation and fracture of solid-state materials
S Yoshida | 380 |
| Strain distribution measurement in laminated martensitic/austenitic steel during a compression test by the electron moiré method
S Kishimoto, Y Tanaka, F Yin, Y Kagawa, and K Nagai | 389 |